

<b>Notice of References Cited</b>	Application/Control No. 09/931,239	Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner David W. Scheuermann	Art Unit 2834	Page 1 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,898,252	04-1999	Tanaka et al.	310/214
	B	US-4,012,652	03-1977	Gilbert, John Derek	310/162
	C	US-2,981,855	04-1961	RIGGS WILLIAM D; et. al.	310/163
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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